Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10511617	SCHULTZ, JUERGEN
Examiner	Art Unit
DEVONA E FAULK	2615

SEARCHED					
Class	Subclass	Date	Examiner		
381	86,91,92	2/3/06	DEF		
381	86,91,92	4/9/2008	DEF		
381	86,91,92,111,122	6/7,7/091	DEF		
381	86,91,92,111,122	12/4/09	DEF		

SEARCH NOTES				
Search Notes	Date	Examiner		
Assignee/Inventor search	2/3/07	DEF		
Reviewed art submitted on IDS	2/3/07	DEF		
Additional search	10/18/07	DEF		
Reviewed applicant's arguments/maintained rejection	4/9/2008	DEF		
additional search	6/7,17/09	DEF		
reviewed applicant's arguments/ maintained rejection	12/4/09	DEF		
additional search	6/7/10	DEF		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
L				

/DEVONA E FAULK/ Primary Examiner.Art Unit 2614

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